Application/Control No.	Applicant(s)/Patent under Reexamination
10/625,909	STURA ET AL.
Examiner	Art Unit
Justin Y. Lee	2617

SEARCHED					
Class	Subclass	Date	Examiner		
Same	Previous Search	7/26/2006	JL		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	7/26/2006	JL		
Duc Nguyen	7/26/2006	JL		